



WANSEMI
万芯半导体

WX043N10KA

Enhancement Mode N-Channel Power MOSFET

TO-220/NMOS/100V/±20V/3.0V/155A/4.3mΩ

Rev0.5

100V, 4.3mΩ, 155A, N-Channel MOSFET

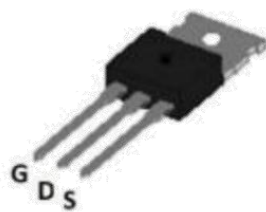
1.Features

- ◆ Advanced Trench Technology
- ◆ Excellent $R_{DS(ON)}$ and Low Gate Charge
- ◆ Lead Free
- ◆ 100% RG Tested
- ◆ 100% UIS Tested

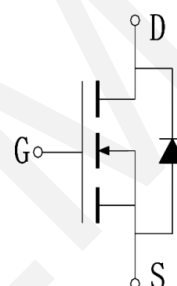
V_{DS}	$R_{DS(on)}$ Typ.	I_D Max.
100V	4.3mΩ @ 10V	155A

2.Applications

- ◆ Load Switch
- ◆ PWM Application
- ◆ Power Management



TO-220
Pin Description



Schematic Diagram

3.Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Tube	PCS/CTN.
WX043N10KA	043N10	TO-220	50	5,000

4.Absolute Max Ratings at $T_a=25^{\circ}\text{C}$ (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V_{DSS}	100	V
Gate to Source Voltage	V_{GSS}	±20	V
Drain Current (DC)	I_D	155	A
Drain Current (Pulse), $PW \leq 300\mu\text{s}$	I_{DP}	620	A
Total Dissipation	P_D	178	W
Avalanche Energy, Single Pulsed	E_{AS}	676	mJ
Junction Temperature	T_j	150	$^{\circ}\text{C}$
Storage Temperature	T_{stg}	-55 to +150	$^{\circ}\text{C}$

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to Ambient	$R_{\theta JA}$	46	$^{\circ}C/W$
Junction to case	$R_{\theta JC}$	0.7	$^{\circ}C/W$

Note 2: When mounted on 1 inch square copper board $t \leq 10$ sec The value in any given application depends on the user's specific board design.

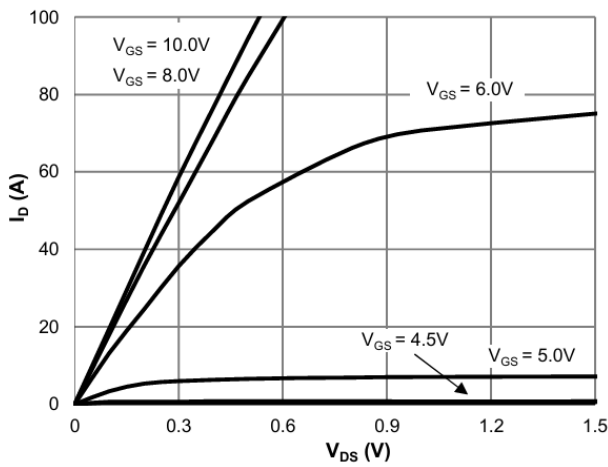
6. Electrical Characteristics at $T_a=25^{\circ}C$ (Note 3)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 250\mu A, V_{GS} = 0V$	100	-	-	V
Zero-Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 100V, V_{GS} = 0V$	-	-	1	μA
Gate to Source Leakage Current	I_{GSS1}	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{DS} = 250\mu A$	2.4	3.0	3.7	V
Static Drain to Source On-State Resistance	$R_{DS(on)}$	$I_D = 20A, V_{GS} = 10V$	-	4.3	5.3	m Ω
Input Capacitance	C_{iss}	$V_{GS} = 0V,$ $V_{DS} = 50V,$ Frequency=1.0MHz	-	3962	-	pF
Output Capacitance	C_{oss}		-	101	-	pF
Reverse Transfer Capacitance	C_{rss}		-	47	-	pF
Turn-on Delay Time	$t_{d(on)}$		-	18	-	ns
Rise Time	t_r	$V_{DS} = 50V, V_{GS} = 10V,$ $R_L = 2.5\Omega, R_{GEN} = 3\Omega$	-	23	-	ns
Turn-off Delay Time	$t_{d(off)}$		-	37	-	ns
Fall Time	t_f		-	15.7	-	ns
Total Gate Charge	Q_g	$V_{DS} = 50V,$ $V_{GS} = 0$ to 10V, $I_D = 20A$	-	69	-	nC
	Q_{gs}		-	24	-	nC
	Q_{gd}		-	18.5	-	nC
Diode Forward Voltage	V_{FSD}	$I_S = 20A, V_{GS} = 0$	-	-	1.2	V

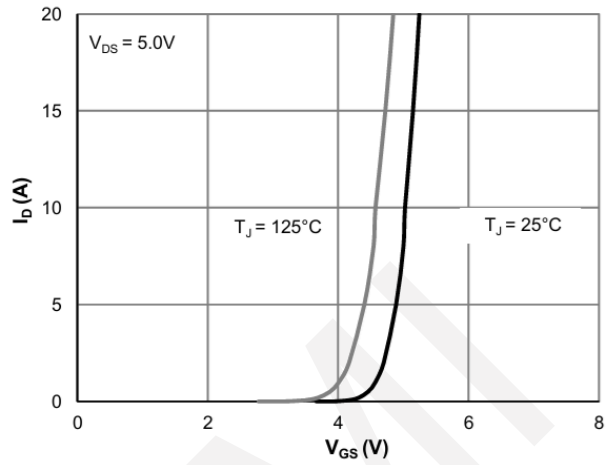
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



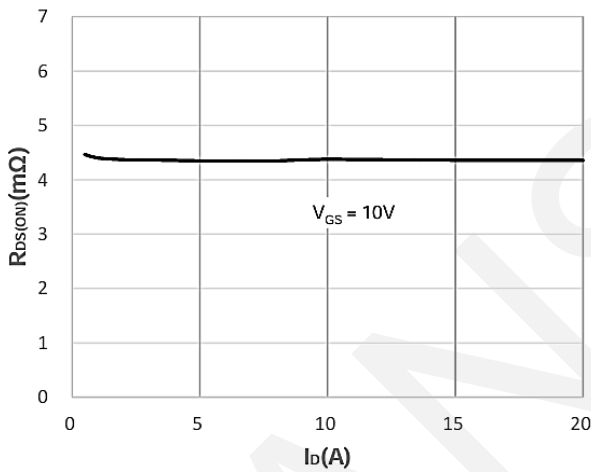
7. Typical electrical and thermal characteristics



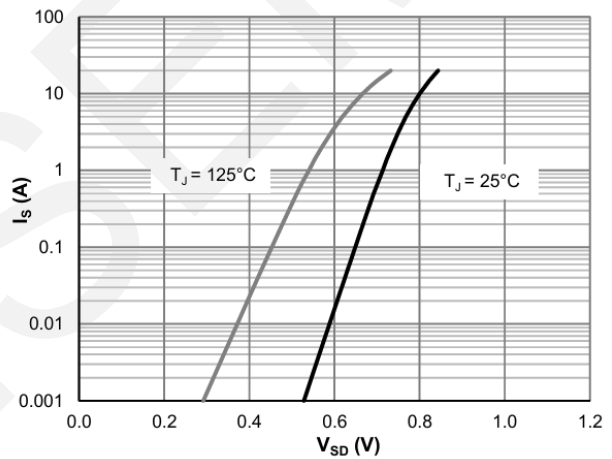
Output Characteristics



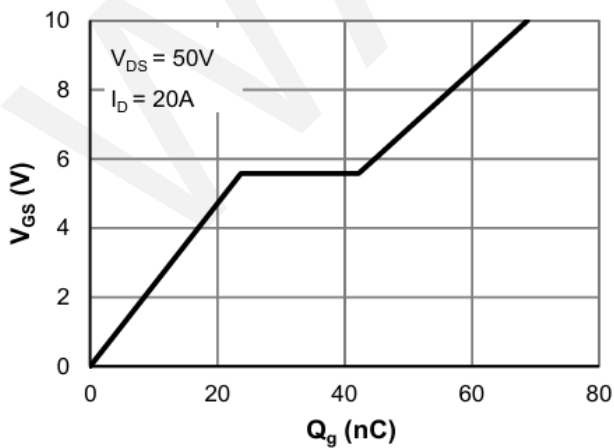
Typical Transfer Characteristics



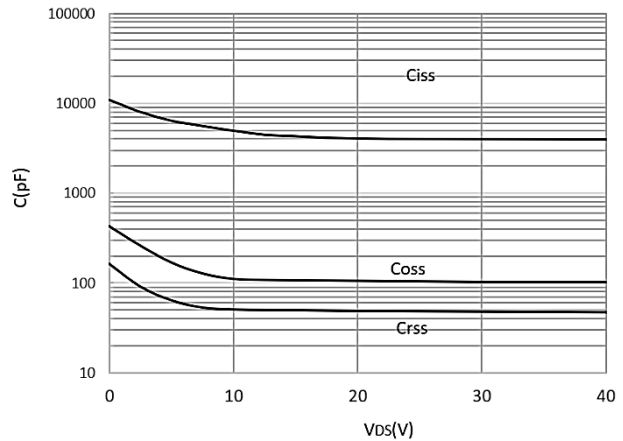
On-resistance vs. Drain Current



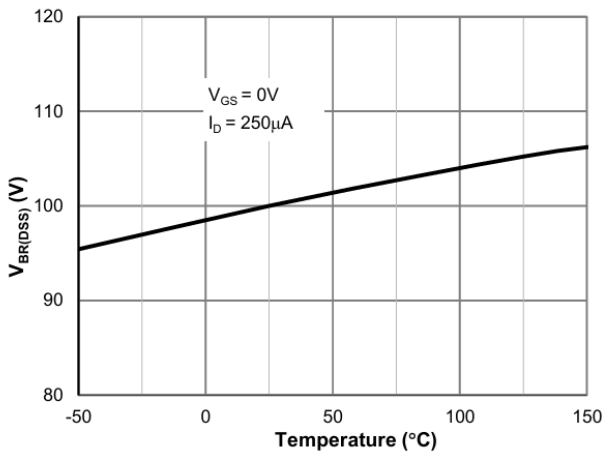
Body Diode Characteristics



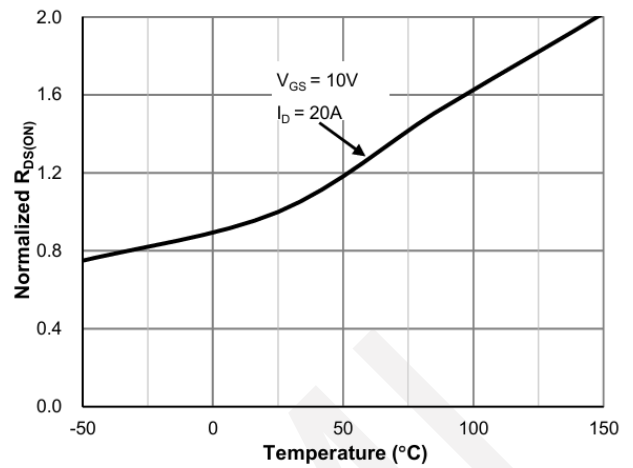
Gate Charge Characteristics



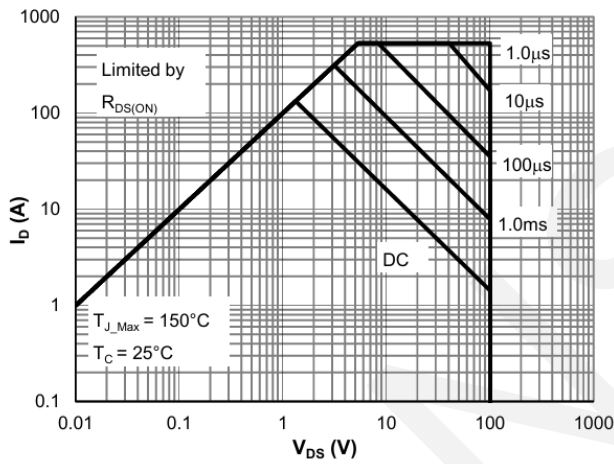
Capacitance Characteristics



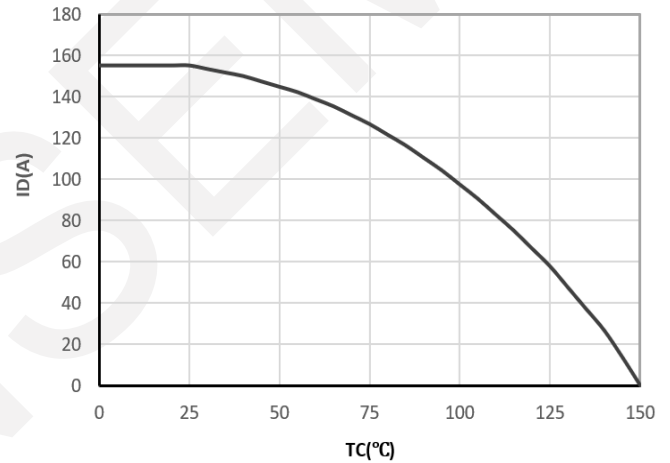
Normalized Breakdown Voltage vs.
Junction Temperature



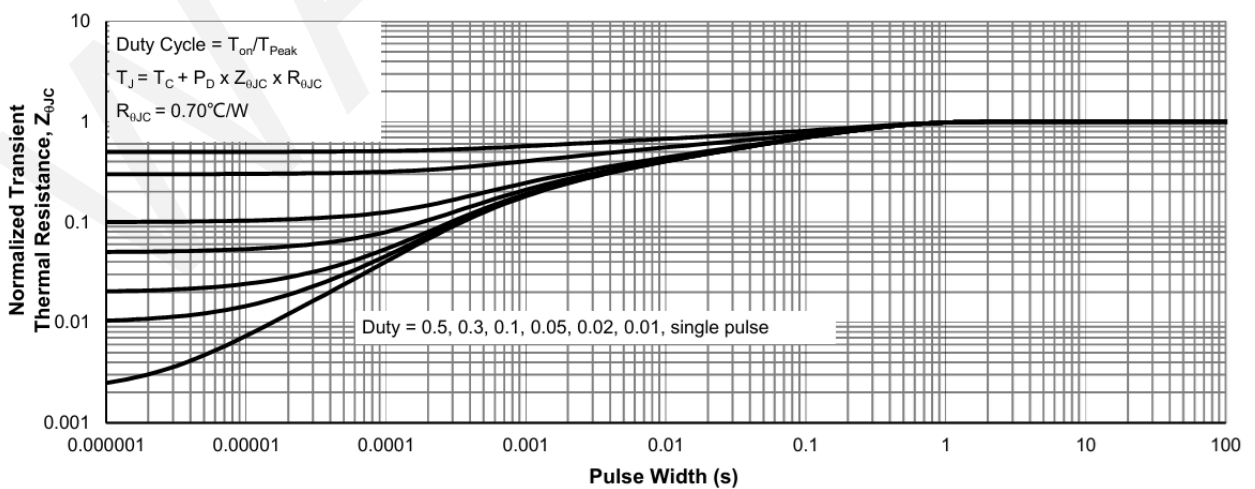
Normalized on Resistance vs.
Junction Temperature



Maximum Safe Operating Area



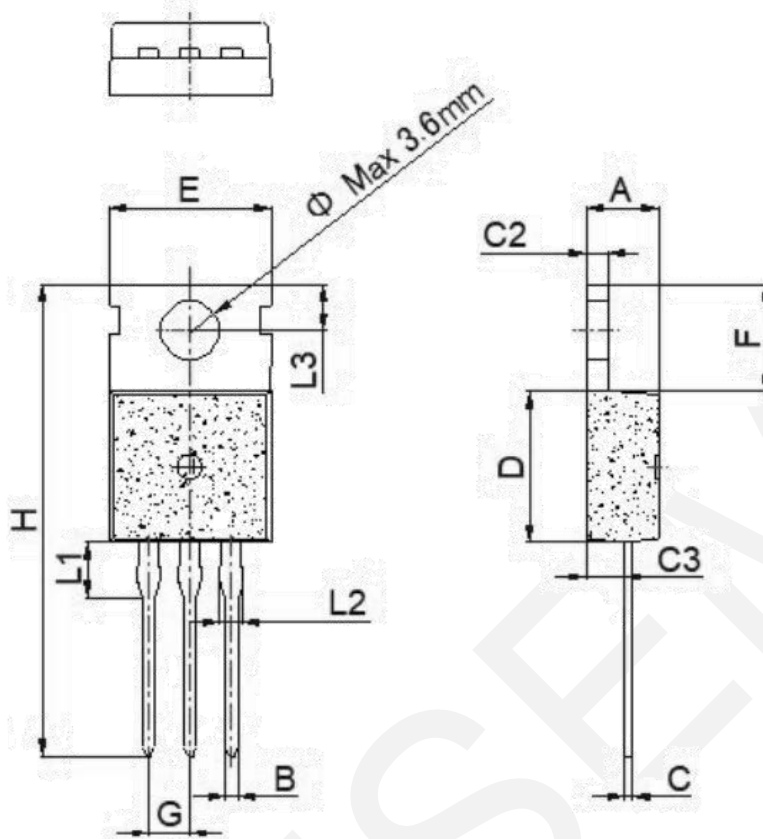
Maximum Continuous Drain Current vs.
Case Temperature



Normalized Maximum Transient
Thermal Impedance



8.Package Dimensions



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	4.40		4.60	0.173		0.181
B	0.70		0.90	0.028		0.035
C	0.45		0.60	0.018		0.024
C2	1.23		1.32	0.048		0.052
C3	2.20		2.60	0.087		0.102
D	8.90		9.90	0.350		0.390
E	9.90		10.3	0.390		0.406
F	6.30		6.90	0.248		0.272
G		2.54			0.1	
H	28.0		29.8	1.102		1.173
L1		3.39			0.133	
L2	1.14		1.70	0.045		0.067
L3	2.65		2.95	0.104		0.116
Φ		3.6			0.142	

9. Important Notice

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